

10/581085

AP3 Rec'd PCT/PTO 31 MAY 2005

PATENT

DK-US065116

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
Junko TAKAHASHI et al. :
Serial No.: New – (National Phase of :
PCT/JP2004/017779) :
International filing date: November 30, 2004 :
For: METHOD OF EXAMINING CHEMICAL :
USING GENE-DISRUPTED STRAIN :

PRELIMINARY AMENDMENT

Assistant Commissioner of Patents
Washington, DC 20231

Sir:

Prior to examination of the above-identified application, please amend the subject application as follows.

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Abstract begin on page 8 of this paper.

Amendments to the Claims are reflected in the Listing of Claims, which begins on page 9 of this paper. Claims 1-23 are pending, with claims 1 and 21-23 being the only independent claims.

Remarks/Arguments begin on page 15 of this paper.